PCMFxUSB3S series

Common-mode EMI filter for differential channels with integrated ESD protection

Rev. 2 — 7 March 2016

Product data sheet

1. Product profile

1.1 General description

Common-mode ElectroMagnetic Interference (EMI) filters with integrated ElectroStatic Discharge (ESD) protection for one, two and three differential channels. The devices are designed to provide low insertion loss for differential high-speed signals on each channel while unwanted common-mode signals are attenuated.

Each differential channel incorporates two signal lines that are coupled by integrated coils. Diodes provide protection to downstream components from ESD voltages up to ± 15 kV on each signal line.

Table 1. Product overview

| Type number | Number of channels | Package Name |
|-------------|--------------------|--------------|
| PCMF1USB3S | 1 | WLCSP5 |
| PCMF2USB3S | 2 | WLCSP10 |
| PCMF3USB3S | 3 | WLCSP15 |

1.2 Features and benefits

- One, two and three differential channels common-mode EMI filters with integrated ESD protection
- ESD protection up to ±15 kV contact discharge according to IEC 61000-4-2
- Superior common-mode suppression over a wide frequency range
- Superior RF performance compared to other integrated filters or discrete filters with external ESD protection
- Extremely high symmetry between line pairs
- Industry-standard Wafer Level Chip Scale Packages: WLCSP5, 10 and 15 for smaller footprint

1.3 Applications

- Smartphone, cellular and cordless phone
- Tablet PC and Mobile Internet Device (MID)
- USB 3.1, USB 2.0, HDMI 2.0, HDMI 1.4
- MIPI M-PHY and D-PHY as used in Camera Serial Interface (CSI) and Display Serial Interface (DSI)
- General-purpose EMI and Radio-Frequency Interference (RFI) filter and downstream ESD protection



2. Pinning information

Table 2. Pinning

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|------|----------------|----------------------|----------------------------|---|
| PCMI | F1USB3S (WLCSI | P5_2-1-2) | | |
| A1 | CH1_IN+ | channel 1+, external | | |
| A2 | CH1_IN- | channel 1-, external | 2 | A1C1 |
| B1 | GND_CH1 | ground channel 1 | (B1) | A2C2 |
| C1 | CH1_OUT+ | channel 1+, internal | | |
| C2 | CH1_OUT- | channel 1-, internal | A B C | 本 本 |
| | | | Transparent top view | |
| | | | WLCSP5_2-1-2 | <u>↓</u> B1 |
| | | | | aaa-019784 |
| PCMI | F2USB3S (WLCSI | P10_4-2-4) | | |
| A1 | CH1_IN+ | channel 1+, external | | |
| A2 | CH1_IN- | channel 1-, external | 4 | A1, 3 — C1, 3 — C2, 4 |
| А3 | CH2_IN+ | channel 2+, external | B2 (B2) | AZ, 4 |
| A4 | CH2_IN- | channel 2-, external | 3 0 | |
| B1 | GND_CH1 | ground channel 1 | | 平 平 |
| B2 | GND_CH2 | ground channel 2 | (B1) | |
| C1 | CH1_OUT+ | channel 1+, internal | | ± B1, B2 - no internal connection |
| C2 | CH1_OUT- | channel 1-, internal | A B C | aaa-019785 |
| C3 | CH2_OUT+ | channel 2+, internal | Transparent top view | |
| C4 | CH2_OUT- | channel 2-, internal | WLCSP10_4-2-4 | |
| PCMI | F3USB3S (WLCSI | P15_6-3-6) | | |
| A1 | CH1_IN+ | channel 1+, external | | |
| A2 | CH1_IN- | channel 1-, external | 6 | A1, 3, 5 C1, 3, 5 A2, 4, 6 C2, 4, 6 |
| А3 | CH2_IN+ | channel 2+, external | B3 (B3) | A2, 4, 6 |
| A4 | CH2_IN- | channel 2-, external | 5 | <u> </u> |
| A5 | CH3_IN+ | channel 3+, external | | 本本 |
| A6 | CH3_IN- | channel 3-, external | B2) | |
| B1 | GND_CH1 | ground channel 1 | 3 | ±_ B1, B2, B3 - no internal connection |
| B2 | GND_CH2 | ground channel 2 | | aaa-019786 |
| В3 | GND_CH3 | ground channel 3 | 2 0 | |
| C1 | CH1_OUT+ | channel 1+, internal | 1 (B1) | |
| C2 | CH1_OUT- | channel 1-, internal | | |
| C3 | CH2_OUT+ | channel 2+, internal | A B C Transparent top view | |
| C4 | CH2_OUT- | channel 2-, internal | WLCSP15_6-3-6 | |
| C5 | CH3_OUT+ | channel 3+, internal | - WECOP 15_0-3-0 | |
| C6 | CH3_OUT- | channel 3-, internal | | |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | | | |
|-------------|---------|---|------------|--|--|
| | Name | Description | Version | | |
| PCMF1USB3S | WLCSP5 | wafer level chip-size package; 5 bumps (2-1-2) | PCMF1USB3S | | |
| PCMF2USB3S | WLCSP10 | wafer level chip-size package; 10 bumps (4-2-4) | PCMF2USB3S | | |
| PCMF3USB3S | WLCSP15 | wafer level chip-size package; 15 bumps (6-3-6) | PCMF3USB3S | | |

4. Marking

Table 4. Marking codes

| <u> </u> | |
|-------------|--------------|
| Type number | Marking code |
| PCMF1USB3S | PF1S |
| PCMF2USB3S | PF2S |
| PCMF3USB3S | PF3S |

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|---------------------------------|---|------|------|------|
| VI | input voltage | | -0.5 | 5 | V |
| V _{ESD} | electrostatic discharge voltage | IEC 61000-4-2, level 4; all input pins to ground | | | |
| | | contact discharge | -15 | 15 | kV |
| | | air discharge | -15 | 15 | kV |
| | | IEC 61000-4-2, level 4; all output pins to ground | | | |
| | | contact discharge | -2 | 2 | kV |
| | | air discharge | -2 | 2 | kV |
| I _{PPM} | rated peak pulse current | t _p = 8/20 μs | -7 | 7 | А |
| T _{stg} | storage temperature | | -40 | +125 | °C |
| T _{amb} | ambient temperature | | -40 | +85 | °C |

6. Characteristics

6.1 Channel characteristics

Table 6. Channel characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------|---------------------------|-----------------------------------|-----|------|-----|------|
| R _{s(ch)} | channel series resistance | single line; input to output | - | 3 | - | Ω |
| C _d | diode capacitance | f = 1 MHz; V _I = 2.5 V | - | 0.25 | - | pF |
| I _{RM} | reverse leakage current | per line; V _I = 5 V | - | - | 100 | nA |
| V_{BR} | breakdown voltage | I _R = 1 mA | 6 | 9 | - | V |
| V _F | forward voltage | I _F = 10 mA | - | 0.8 | - | V |
| R _{dyn} | dynamic resistance | TLP [2] | | | | |
| | | positive transient | - | 0.14 | - | Ω |
| | | negative transient | - | 0.14 | - | Ω |
| | | surge [3] | | | | |
| | | positive transient | - | 0.22 | - | Ω |
| | | negative transient | - | 0.22 | - | Ω |

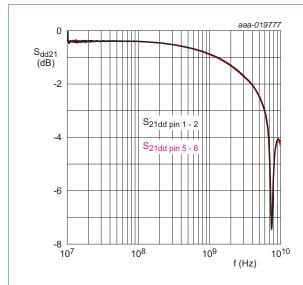
- [1] This parameter is guaranteed by design.
- [2] 100 ns Transmission Line Pulse (TLP); 50 W; pulser at 70 ns to 90 ns.
- [3] According to IEC 61000-4-5 (8/20 ms).

6.2 Frequency characteristics

Table 7. Frequency characteristics

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|---------------|-----------------------------|-------------|------------|-----|-----|-----|------|
| Common | mode: S _{21cc} | | | | ' | | ' |
| α_{il} | insertion loss | | [1] | | | | |
| | | f = 800 MHz | | - | -12 | - | dB |
| | | f = 2.6 GHz | | - | -38 | - | dB |
| | | f = 5 GHz | | - | -18 | - | dB |
| Different | ial mode: S _{21dd} | | | | ' | ' | • |
| α_{il} | insertion loss | f = 1 MHz | [1] | - | 0.3 | - | dB |
| f_3dB | cut-off frequency | | <u>[1]</u> | - | 6 | - | GHz |

^[1] Normalized to attenuation at 1 MHz.



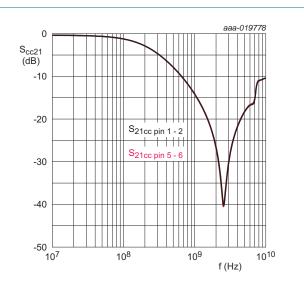
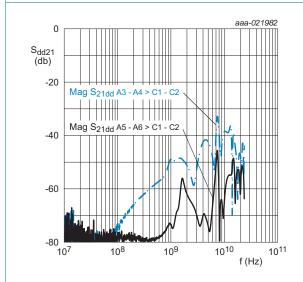


Fig 1. Differential-mode insertion loss; typical values





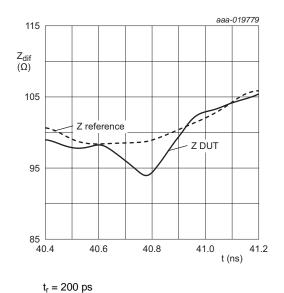
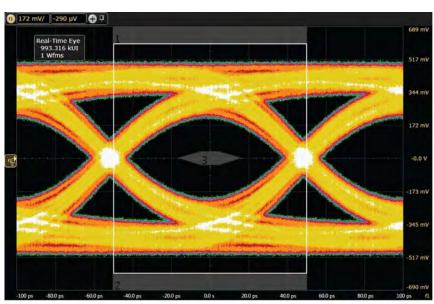


Fig 3. Differential crosstalk; typical values

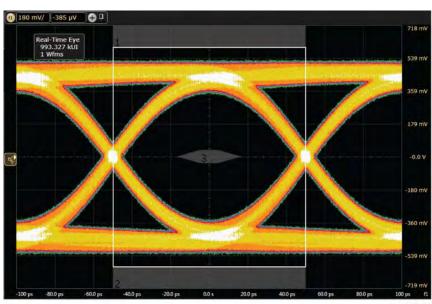
Fig 4. Differential Time Domain Reflectometer (TDR) plot; typical values



aaa-022137

Data rate: 10 Gbit/s Vertical scale: 173 mV/div Horizontal scale: 20 ps/div

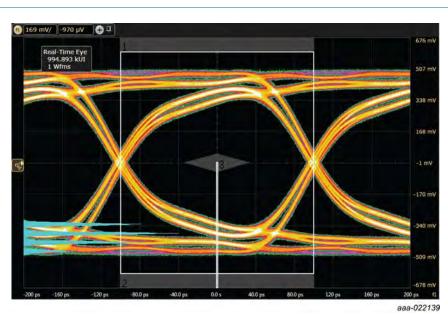
Fig 5. USB 3.1 eye diagram, test board with PCMF2USB3S; typical values



aaa-022138

Data rate: 10 Gbit/s Vertical scale: 180 mV/div Horizontal scale: 20 ps/div

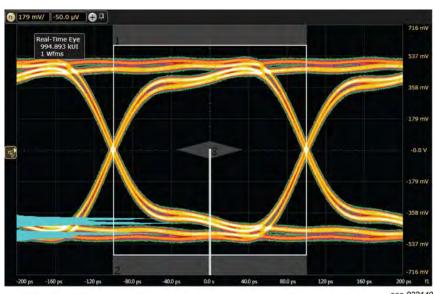
Fig 6. USB 3.1 eye diagram, test board without device; typical values



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Data rate: 5 Gbit/s Vertical scale: 169 mV/div Horizontal scale: 40 ps/div

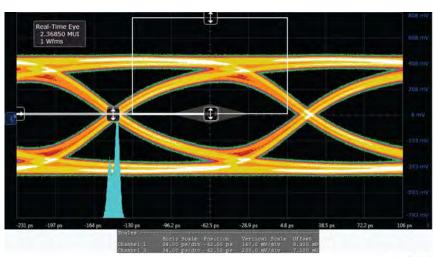
Fig 7. USB 3.1 eye diagram, test board with PCMF2USB3S; typical values



aaa-022140

Data rate: 5 Gbit/s Vertical scale: 179 mV/div Horizontal scale: 40 ps/div

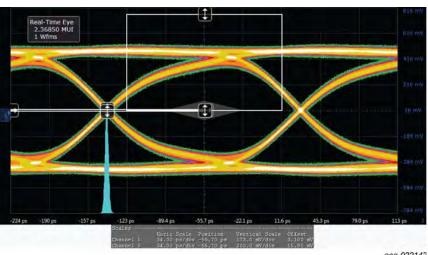
Fig 8. USB 3.1 eye diagram, test board without device; typical values



aaa-022141

Test frequency: 148.5 MHz Differential swing voltage: 861 mV Horizontal scale: 34 ps/div

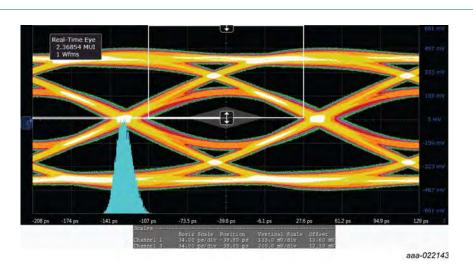
Fig 9. HDMI 2.0 eye diagram TP1, test board with PCMF2USB3S; typical values



aaa-022142

Test frequency: 148.5 MHz Differential swing voltage: 917 mV Horizontal scale: 34 ps/div

Fig 10. HDMI 2.0 eye diagram TP1, test board without device; typical values

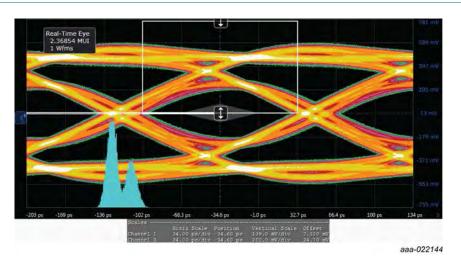


Test frequency: 148.5 MHz Differential swing voltage: 849 mV Horizontal scale: 34 ps/div

Remark: Measured at Test Point 2 (TP2) worst cable emulator, reference cable equalizer and

worst case positive skew.

Fig 11. HDMI 2.0 eye diagram TP2, test board with PCMF2USB3S; typical values



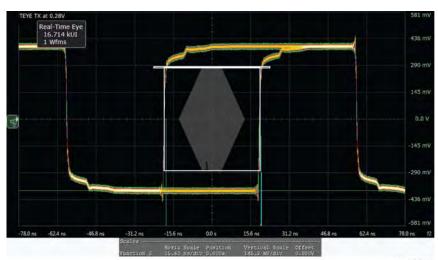
Test frequency: 148.5 MHz Differential swing voltage: 909 mV

Horizontal scale: 34 ps/div

Remark: Measured at Test Point 2 (TP2) worst cable emulator, reference cable equalizer and

worst case positive skew.

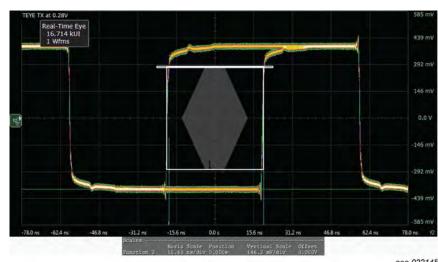
Fig 12. HDMI 2.0 eye diagram TP2, test board without device; typical values



aaa-022146

Vertical scale: 145 mV/div Horizontal scale: 15.6 ns/div

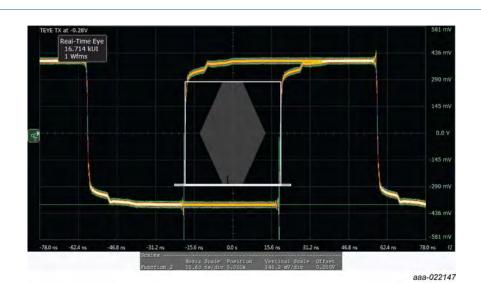
Fig 13. MIPI M-PHY PWM-TX transmitter eye opening at 140 mV, test board with PCMF2USB3S; typical values



aaa-022148

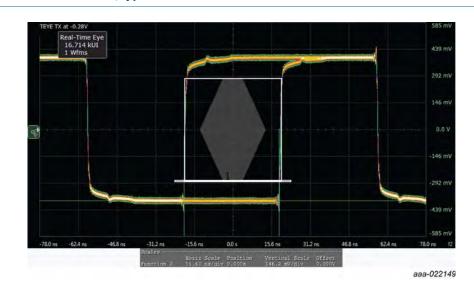
Vertical scale: 146 mV/div Horizontal scale: 15.6 ns/div

Fig 14. MIPI M-PHY PWM-TX transmitter eye opening at 140 mV, test board without device; typical values



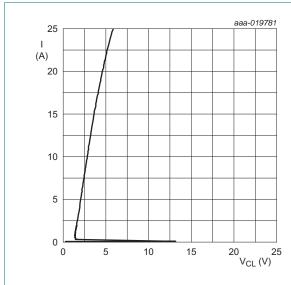
Vertical scale: 145 mV/div Horizontal scale: 15.6 ns/div

Fig 15. MIPI M-PHY PWM-TX transmitter eye opening at -140 mV, test board with PCMF2USB3S; typical values



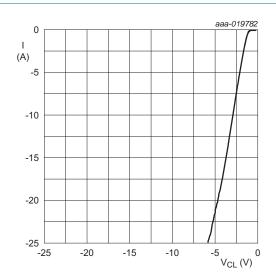
Vertical scale: 146 mV/div Horizontal scale: 15.6 ns/div

Fig 16. MIPI M-PHY PWM-TX transmitter eye opening at -140 mV, test board without device; typical values



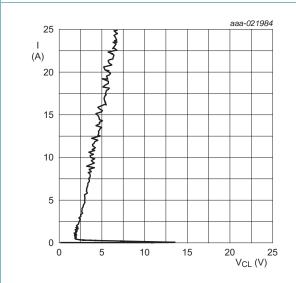
Transmission Line Pulse (TLP) = 100 ns;

Fig 17. Dynamic resistance with positive clamping; typical values



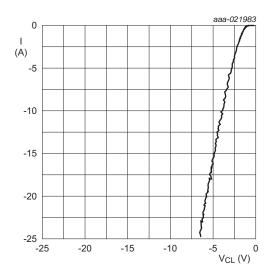
Transmission Line Pulse (TLP) = 100 ns; $t_r = 1 \text{ ns}$

Fig 18. Dynamic resistance with negative clamping; typical values



Very-Fast Transmission Line Pulse (VF-TLP) = 5 ns; $t_r = 600 \text{ ps}$

Fig 19. Dynamic resistance with positive clamping; typical values



Very-Fast Transmission Line Pulse (VF-TLP) = 5 ns; t_r = 600 ps

Fig 20. Dynamic resistance with negative clamping; typical values

The device uses an advanced clamping structure showing a negative dynamic resistance. This snapback behavior strongly reduces the clamping voltage to the system behind the ESD protection during an ESD event. Do not connect unlimited DC current sources to the data lines to avoid keeping the ESD protection device in snapback state after exceeding breakdown voltage (due to an ESD pulse for instance).

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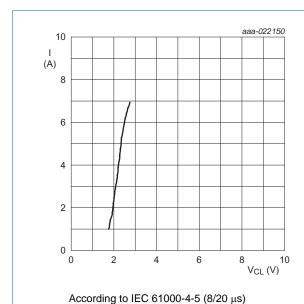
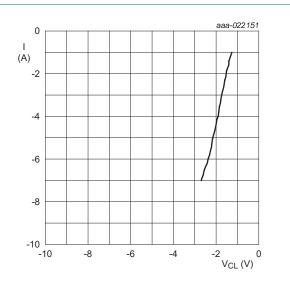


Fig 21. Dynamic resistance with positive clamping; typical values



According to IEC 61000-4-5 (8/20 μs)

Dynamic resistance with negative class

7. Application information

The device is designed to provide high-level ESD protection and common-mode filtering for differential high-speed data line pairs such as:

- USB 3.1
- HDMI 2.0
- Transition-Minimized Differential Signaling (TMDS)
- DisplayPort
- external Serial Advanced Technology Attachment (eSATA)
- Low Voltage Differential Signaling (LVDS)

When designing the PCB, give careful consideration to impedance matching and signal coupling. Do not connect the protected signal lines to unlimited current sources like, for example, a battery.

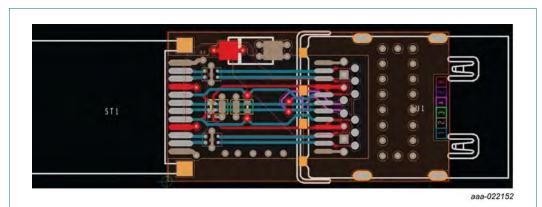


Fig 23. Application diagram: protecting and filtering the differential data lines of a USB Type-C connector evaluation dongle with PCMF1USB3S

Since the SuperSpeed TX/RX lines are separated by GND or VBUS from the Hi-Speed lines, PCMF1USB3S makes it easy to achieve same signal lengths, straight routing, and optimal positioning for ESD protection directly at the connector.

8. Package outline

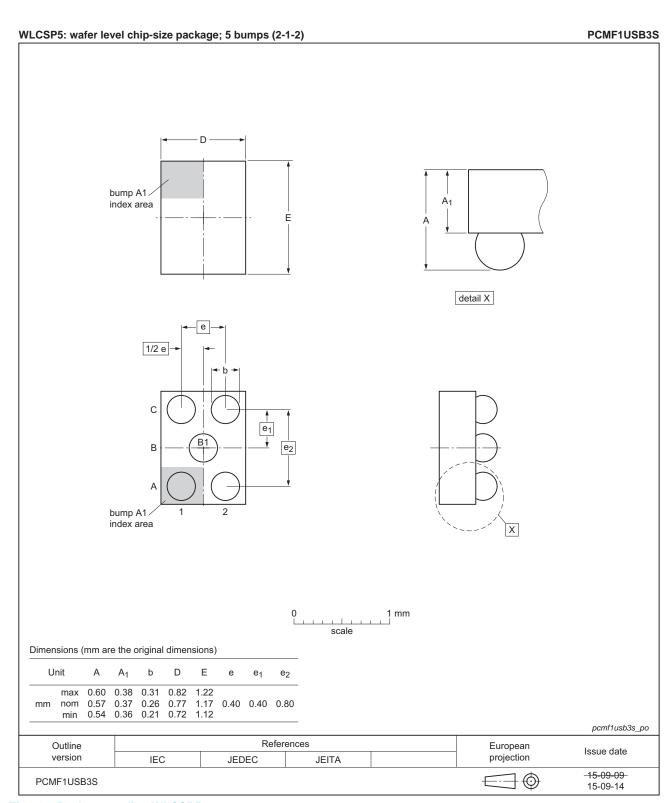


Fig 24. Package outline WLCSP5

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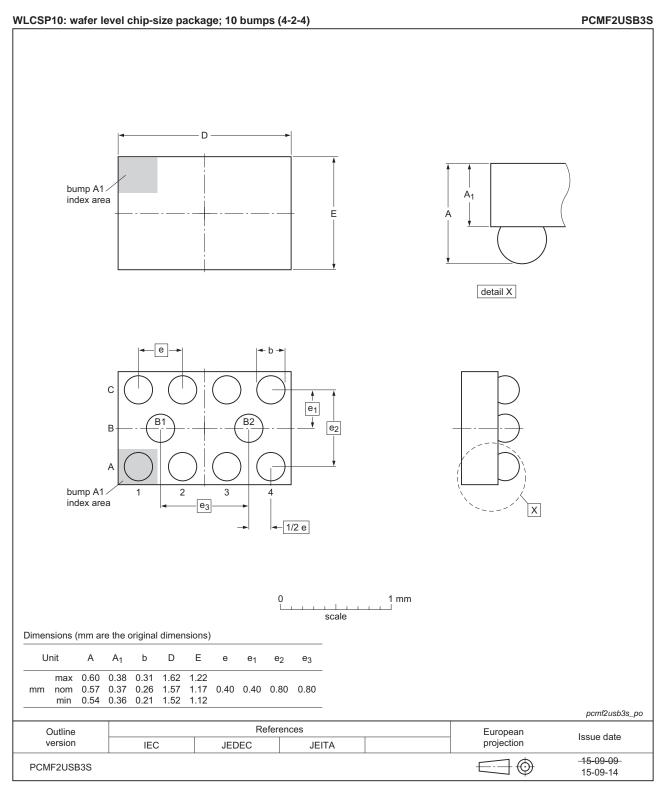


Fig 25. Package outline WLCSP10

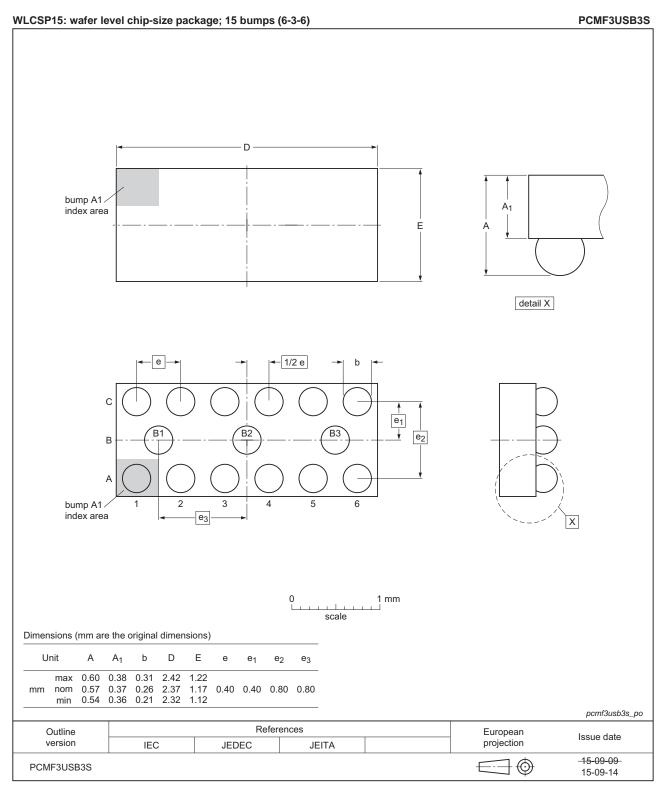


Fig 26. Package outline WLCSP15

9. Soldering

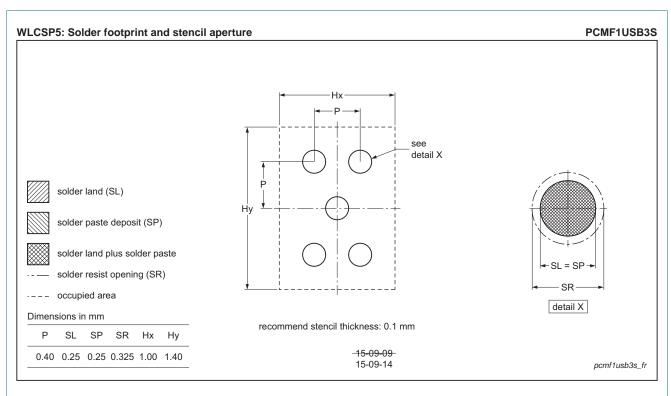


Fig 27. Soldering footprint WLCSP5 (PCMF1USB3S)

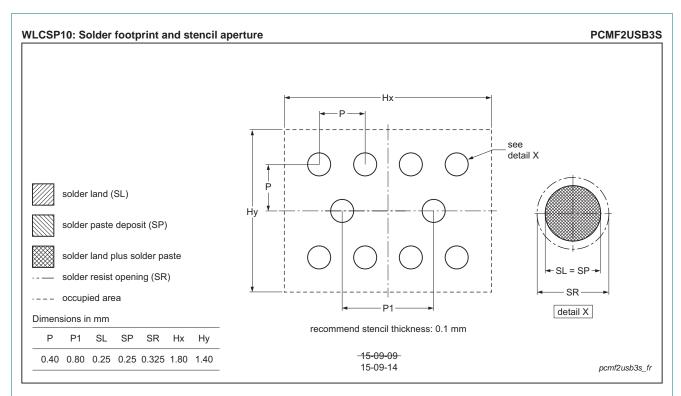
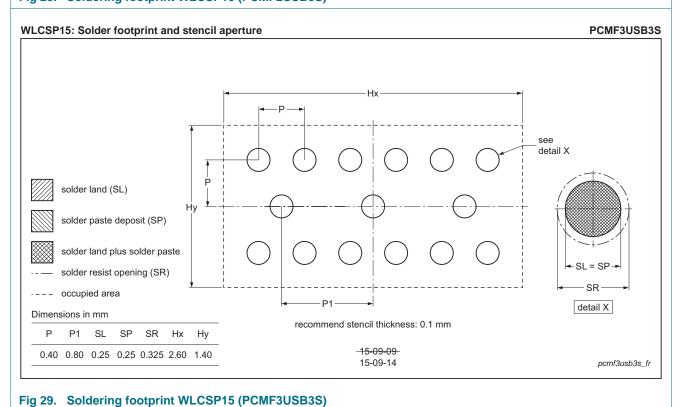


Fig 28. Soldering footprint WLCSP10 (PCMF2USB3S)



PCMFxUSB3S series

Common-mode EMI filter for differential channels with ESD protection

10. Revision history

Table 8. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|--------------------|------------------------------------|------------------------|---------------|--------------------|
| PCMFXUSB3S_SER v.2 | 20160307 | Product data sheet | - | PCMFXUSB3S_SER v.1 |
| Modifications: | Product status | changed | | |
| PCMFXUSB3S_SER v.1 | 20151007 | Preliminary data sheet | - | - |

11. Legal information

11.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
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- [2] The term 'short data sheet' is explained in section "Definitions"
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PCMFxUSB3S series

Common-mode EMI filter for differential channels with ESD protection

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Common-mode EMI filter for differential channels with ESD protection

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